

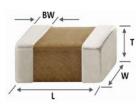


Specification of Automotive MLCC (Reference sheet)

- Supplier : Samsung electro-mechanics
- Product : Multi-layer Ceramic Capacitor
- Samsung P/N : CL10C221JC81PNC
- Description : CAP, 220pF, 100V, ± 5%, C0G, 0603
- AEC-Q200 Qualified

A. Dimension

Dimension



Size	0603 inch
L	1.60±0.10 mm
W	0.80±0.10 mm
Т	0.80±0.10 mm
BW	0.30±0.20 mm

B. Samsung Part Number

1 Series

	<u>CL</u> ①	<u>10</u> ②	<u>С</u> 3	<u>221</u> ④	<mark>_</mark> 5	<u>C</u> 6	<u>8</u> T	<u>1</u> ®	<u>P</u> 9	<u>N</u> 10	<u>C</u> 11	
Sa	amsung I	Multi-lay	yer Cera	amic Capa	acitor							
	060)3 (in	ch code	e)		L: 1.0	60±0.10	mm		W: 0.	80±0.10	mm

② Size	0603 (inch code)	L: 1.60±0.10 mm	W: 0.80±0.10 mm
③ Dielectric	C0G	⑧ Inner electrode	Ni
④ Capacitance	220 pF	Termination	Cu
⑤ Capacitance	± 5%	Plating	Sn 100% (Pb Free)
tolerance		9 Product	Automotive
⑥ Rated Voltage	100 V	Special code	Normal
⑦ Thickness	0.80±0.10 mm	① Packaging	Cardboard Type, 7" Reel

C. Reliability Test and Judgement condition

Performance	Test condition			
Appearance : No abnormal exterior appearance	Unpowered, 1,000hrs @ Max. temperature			
Capacitance Change : Within ±2.5% or ±0.25pF	Measurement at 24±2hrs after test conclusion			
whichever is larger				
Q : 1,000 min.				
IR : More than 10,000 ^M Ω or 500 ^M Ω× <i>μ</i> F				
Whichever is smaller				
Appearance : No abnormal exterior appearance	1,000Cycles			
Capacitance Change : Within ±2.5% or ±0.25pF	Measurement at 24±2hrs after test conclusion			
whichever is larger				
Q : 1,000 min.	1 cycle condition : -55+0/-3 °C (30±3min) → Room Temp. (1min)			
IR : More than 10,000 № or 500 №× <i>µ</i> F	→ 125+3/-0 °C (30±3min) → Room Temp. (1min)			
Whichever is smaller				
No Defects or abnormalities	Per EIA 469			
Appearance : No abnormal exterior appearance	1,000hrs 85 °C/85%RH, Rated Voltage and 1.3~1.5V,			
Capacitance Change : Within ±2.5% or ±0.25pF	Add 100kohm resistor			
whichever is larger				
Q : 200 min.	The charge/discharge current is less than 50mA.			
IR : More than 500 ^M Ω or 25 ^M Ω×μF				
Whichever is smaller				
Appearance : No abnormal exterior appearance	1,000hrs @ 125 °C, 200% Rated Voltage,			
Capacitance Change : Within ±3% or ±0.3pF	Measurement at 24±2hrs after test conclusion			
whichever is larger	The charge/discharge current is less than 50mA.			
Q : 350 min.				
IR : More than 1.000 № or 50 №× <i>μ</i> F				
$11R$. WOIE (11a) 1,000 MM 01 50 MM $\wedge \mu$				
	Appearance : No abnormal exterior appearance Capacitance Change : Within ±2.5% or ±0.25pF whichever is larger Q : 1,000 min. IR : More than 10,000 MQ or 500 MQ×µF Whichever is smaller Appearance : No abnormal exterior appearance Capacitance Change : Within ±2.5% or ±0.25pF whichever is larger Q : 1,000 min. IR : More than 10,000 MQ or 500 MQ×µF Whichever is larger Q : 1,000 min. IR : More than 10,000 MQ or 500 MQ×µF Whichever is smaller No Defects or abnormal exterior appearance Capacitance Change : Within ±2.5% or ±0.25pF whichever is larger Q : 200 min. IR : More than 500 MQ or 25 MQ×µF whichever is smaller Appearance : No abnormal exterior appearance Capacitance Change : Within ±2.5% or ±0.25pF whichever is larger Q : 200 min. IR : More than 500 MQ or 25 MQ×µF Whichever is smaller Appearance : No abnormal exterior appearance Capacitance Change : Within ±3% or ±0.3pF whichever is larger Q : 350 min.			

	Performance	Test condition				
External Visual	No abnormal exterior appearance	Microscope ('10)				
Physical Dimensions	Within the specified dimensions	Using The calipers				
Mechanical Shock	Appearance : No abnormal exterior appearance	Three shocks in each direction should be applied along				
	Capacitance Change : Within ±2.5% or ±0.25pF	3 mutually perpendicular axes of the test specimen (18 shocks)				
	whichever is larger	Peak value Duration Wave Velocity				
		1,500G 0.5ms Half sine 4.7m/sec				
	Q, IR : Initial spec.					
Vibration	Appearance : No abnormal exterior appearance	5g's for 20min., 12cycles each of 3 orientations,				
	Capacitance Change : Within ±2.5% or ±0.25pF	Use 8"×5" PCB 0.031" Thick 7 secure points on one long side				
	whichever is larger	and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from $10~2,000$ Hz.				
	Q, IR : Initial spec.					
Resistance to	Appearance : No abnormal exterior appearance	Preheating : 150°C for 60~120 sec.				
Solder Heat	Capacitance Change : Within ±2.5% or ±0.25pF	Solder pot : 260±5°C, 10±1sec.				
	whichever is larger					
	Q, IR : Initial spec. Appearance : No abnormal exterior appearance					
ESD	Capacitance Change : Within $\pm 2.5\%$ or ± 0.25 pF	AEC-Q200-002 or ISO/DIS10605				
	whichever is larger					
	Q, IR : Initial spec.					
Solderability	95% of the terminations is to be soldered	a) Preheat at 155 $^\circ\!\!\!\mathrm{C}$ for 4 hours, Immerse in solder for 5s at 245±5 $^\circ\!\!\!\mathrm{C}$				
,	evenly and continuously	b) Steam aging for 8 hours, Immerse in solder for 5s at 245±5 $^\circ \!$				
		c) Steam aging for 8 hours, Immerse in solder for 120s at 260±5 $^\circ \!\! C$				
		solder : a solution ethanol and rosin				
Electrical	Capacitance : Within specified tolerance	The Capacitance / D.F. should be measured at 25 °C,				
Characterization	Q : 1,000 min.	1 ^{Ml} z ± 10%, 0.5~5 Vrms				
	IR(25℃): More than 100,000 ^M or 1,000 ^M ×µ ^F	I.R. should be measured with a DC voltage not exceeding				
	Whichever is smaller.	Rated Voltage @25°C, @125°C for 60~120 sec.				
	IR(125 °C): More than 10,000 M ^Q or 100 M ^Q × μ F					
	Whichever is smaller.					
	Dielectric Strength	Dielectric Strength : 200% of the rated voltage for 1~5 seconds				
Board Flex	Appearance : No abnormal exterior appearance	Bending to the limit, 3 mm for 60 seconds				
	Capacitance Change : Within $\pm 5\%$ or $\pm 0.5 \text{pF}$					
	whichever is larger					
Terminal	Appearance : No abnormal exterior appearance	10 N, for 60 sec.				
Strength(SMD)	Capacitance Change : Within ±2.5% or ±0.25pF					
	whichever is larger					
Beam Load	Destruction value should be exceed 20 N	Beam speed : 0.5±0.05 mm/sec				
Temperature	C0G					
Characteristics	From -55 °C to 125 °C, Capacitance change should	be within 0±30ppm/°C				

D. Recommended Soldering method :

Reflow (Reflow Peak Temperature : 260 +0/-5 $^\circ C$, 30sec.), Meet IPC/JEDEC J-STD-020 D Standard

A Product specifications included in the specifications are effective as of March 1, 2013.

Please be advised that they are standard product specifications for reference only.

We may change, modify or discontinue the product specifications without notice at any time.

So, you need to approve the product specifications before placing an order.

Should you have any question regarding the product specifications, please contact our sales personnel or application engineers.

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- Aerospace/Aviation equipment
- ② Medical equipment
- *③ Military equipment*
- ④ Disaster prevention/crime prevention equipment
- *5* Power plant control equipment
- 6 Atomic energy-related equipment
- ⑦ Undersea equipment
- ⑧ Traffic signal equipment
- Data-processing equipment
- 10 Electric heating apparatus, burning equipment
- ${\it I\!\! D}$ Safety equipment
- 2 Any other applications with the same as or similar complexity or reliability to the applications